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Terrestrial Laserscanning - Modeling of Correlations and Point Clouds for Deformation Analysis

Corinna Harmening, Stephanie Kauker, Hans Neuner, Volker Schwieger

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Outline

- ① Motivation
- ② Modelling of correlations
- ③ Modelling of the areal trend component
- ④ Conclusion

Motivation



Fig.1: Scanning HFT Stuttgart

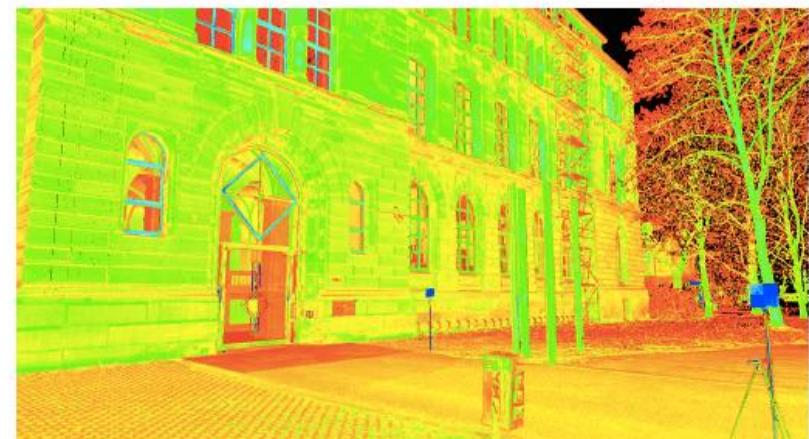


Fig.2: Point cloud of HFT scan

- **Goal:** detecting deformation on any point on an object surface
- **Observations:** horizontal rotation angle, vertical rotation angle, slope distance
- Substantial error sources cause **stochastical relations** within a point cloud

Motivation (cont'd)

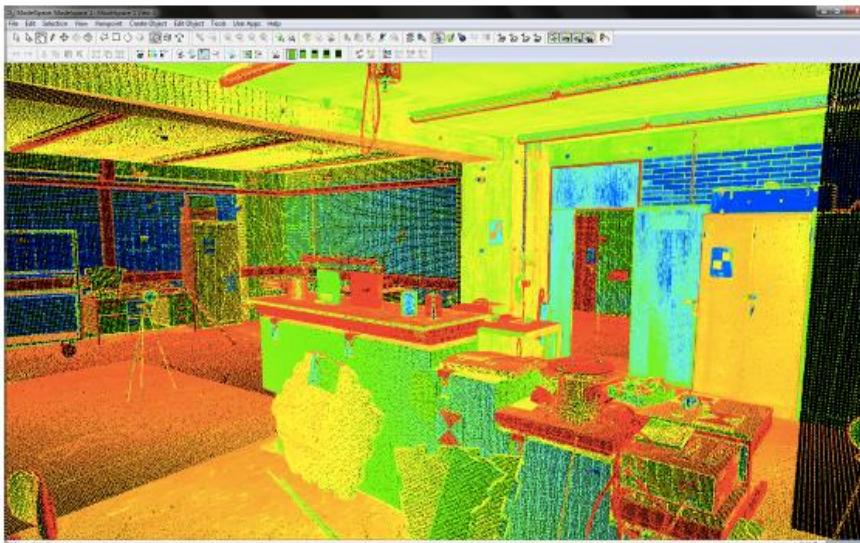


Fig.3: Point cloud of test room, US



Fig.4: Leica HDS 7000

- Detection by high-resolution data of terrestrial laser scanners
 - **Highly correlated** data
- Reproducing points from epoch to epoch
 - Development of **non-linear spatio-temporal** method for modelling a time-varying object surface

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Synthetic covariance matrix

- **Multidimensional** measured values and random deviations
 - **Classification** of elementary errors
 - Requirement of **influencing** and **covariance matrices**
 1. **Non-correlating** errors: D_k , $\Sigma_{\delta\delta,k}$
 2. **Functional correlating** errors: F , $\Sigma_{\xi\xi}$
 3. **Stochastic correlating** errors: G_h , $\Sigma_{\gamma\gamma,h}$
- **Synthetic covariance matrix**

$$\Sigma_{ll} = \underbrace{\sum_{k=1}^p D_k \cdot \Sigma_{\delta\delta,k} \cdot D_k^T}_{\text{non-correlating}} + \underbrace{F \cdot \Sigma_{\xi\xi} \cdot F^T}_{\text{functional correlating}} + \underbrace{\sum_{h=1}^q G_h \cdot \Sigma_{\gamma\gamma,h} \cdot G_h^T}_{\text{stochastic correlating}}$$



Synthetic covariance matrix (cont'd)

■ Non-correlating

$$\mathbf{D}_k = \begin{bmatrix} \frac{\partial l_1}{\partial \delta_{1k}} & 0 & \cdots & 0 \\ 0 & \frac{\partial l_2}{\partial \delta_{2k}} & 0 & \vdots \\ \vdots & 0 & \ddots & \vdots \\ 0 & \cdots & \cdots & \frac{\partial l_n}{\partial \delta_{nk}} \end{bmatrix}$$

■ Functional correlating

$$\mathbf{F} = \begin{bmatrix} \frac{\partial l_1}{\partial \xi_1} & \frac{\partial l_1}{\partial \xi_2} & \cdots & \frac{\partial l_1}{\partial \xi_m} \\ \frac{\partial l_2}{\partial \xi_1} & \frac{\partial l_2}{\partial \xi_2} & \cdots & \frac{\partial l_2}{\partial \xi_m} \\ \vdots & \vdots & \ddots & \vdots \\ \frac{\partial l_n}{\partial \xi_1} & \frac{\partial l_n}{\partial \xi_2} & \cdots & \frac{\partial l_n}{\partial \xi_m} \end{bmatrix}$$

■ Stochastic correlating

$$\mathbf{G}_h = \begin{bmatrix} \frac{\partial l_1}{\partial \gamma_{1h}} & 0 & \cdots & 0 \\ 0 & \frac{\partial l_2}{\partial \gamma_{2h}} & 0 & \vdots \\ \vdots & 0 & \ddots & \vdots \\ 0 & \cdots & \cdots & \frac{\partial l_n}{\partial \gamma_{nh}} \end{bmatrix}$$

$$\boldsymbol{\Sigma}_{\delta\delta,k} = \begin{bmatrix} \sigma_{1k}^2 & 0 & \cdots & 0 \\ 0 & \sigma_{2k}^2 & 0 & \vdots \\ \vdots & 0 & \ddots & \vdots \\ 0 & \cdots & \cdots & \sigma_{nk}^2 \end{bmatrix}$$

$$\boldsymbol{\Sigma}_{\xi\xi} = \begin{bmatrix} \sigma_1^2 & 0 & \cdots & 0 \\ 0 & \sigma_2^2 & 0 & \vdots \\ \vdots & 0 & \ddots & \vdots \\ 0 & \cdots & \cdots & \sigma_n^2 \end{bmatrix}$$

$$\boldsymbol{\Sigma}_{\gamma\gamma,h} = \begin{bmatrix} \sigma_{1h}^2 & \sigma_{12h} & \cdots & \sigma_{1nh} \\ \sigma_{12h} & \sigma_{2h}^2 & \cdots & \sigma_{2nh} \\ \vdots & \vdots & \ddots & \vdots \\ \sigma_{1nh} & \sigma_{2nh} & \cdots & \sigma_{nh}^2 \end{bmatrix}$$

Elementary
errors

No correlations

No correlations

Correlations

Observations

No correlations

Correlations

Correlations



Elementary errors of terrestrial laser scanners

- **Assumption:** the main error sources of a total station appear for a terrestrial laser scanner
- **Definition and classification** of the elementary errors

Correlation	Error	Correlation	Error
Non	Noise *		Angle of incidence Edges
Stochastic	Penetration depth Roughness Reflectivity Colour Temperature * Pressure * Partial water vapour pressure *	Functional	Range finder * Zero point * Collimation axis * Horizontal axis * Vertical collimation * Tumbling error * Eccentricity of the col- limation axis *

* Considered for simulation

Legend: Instrumental, atmospheric, object based

Simulation and results

- Change of range

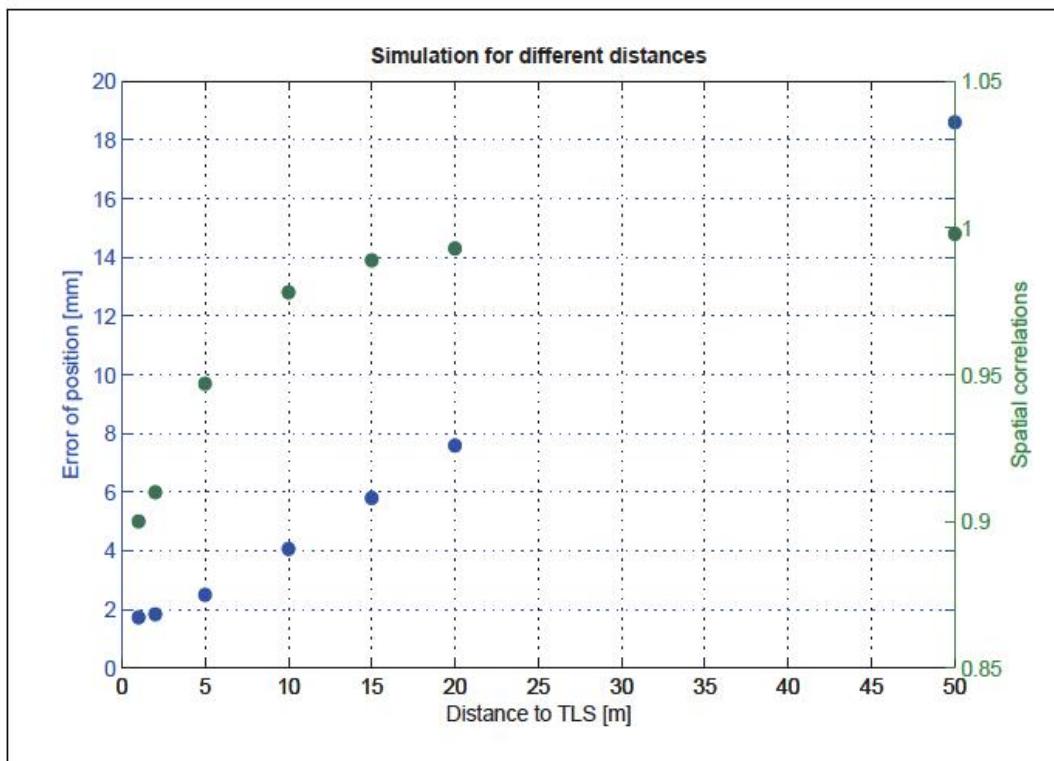


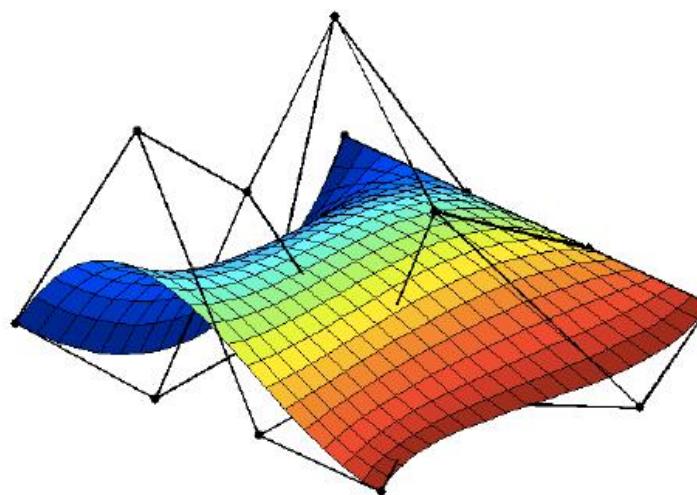
Fig. 9: Effect of different distances

- Dependency between range and spatial correlations
- Rise of distance leads to increasing correlations and worsening of positional error

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Modelling of point clouds using B-splines



B-spline surface to model point clouds

$$\hat{\mathbf{S}}(u, v) = \mathbf{S}(u, v) + \mathbf{e} = \sum_{i=0}^n \sum_{j=0}^m N_{i,p}(u) N_{j,q}(v) \mathbf{P}_{ij}$$

$\mathbf{S}(u, v)$: surface point with surface parameters u and v

\mathbf{e} : residuals

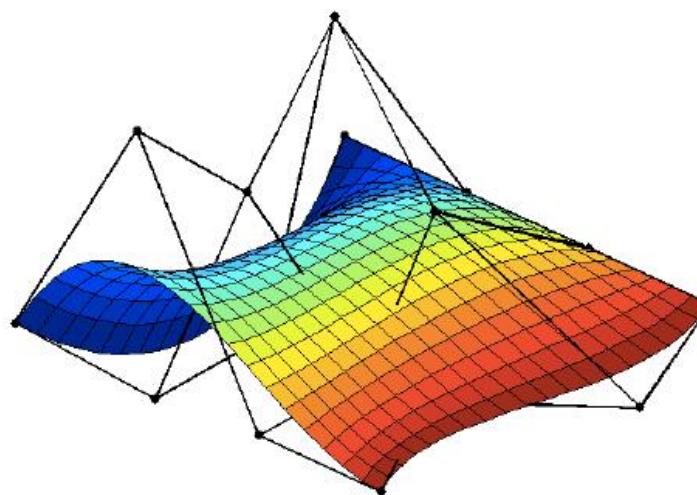
\mathbf{P}_{ij} : $(n+1)x(m+1)$ control points

$N_{i,p}(u)$: i -th B-spline basis function of degree p

$N_{j,q}(v)$: j -th B-spline basis function of degree q



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Model selection

■ Basic principles of model selection

- Choosing a model out of a set of candidate models
- Information criteria evaluate each model
- Based on Maximum Likelihood (ML) Theory

■ Asymptotic efficient criteria

- Phenomenon has infinite dimension
- Best approximation of the true phenomenon
- Minimizing a distance measure
- Example: AIC

■ Asymptotic consistent criteria

- Phenomenon has finite dimension
- True dependency is contained in the set of candidate models
- Identifying the true dependency
- Example: BIC



Model selection by AIC and BIC

■ Akaike Information Criterion (AIC)

- Asymptotic efficient
- Optimal model minimizes the Kullback-Leibler-distance
- $AIC = -2 \log(\mathcal{L}(\hat{\theta}|y)) + 2K$

■ Bayesian Information Criterion (BIC)

- Asymptotic consistent
- Optimal model is a posteriori most likely
- $BIC = -2 \log(\mathcal{L}(\hat{\theta}|y)) + K \log(l)$

■ AIC and BIC

- Based on two completely different concepts
- Penalized log-likelihood criteria
- Find a balance between approximation quality and complexity
- BIC's penalty is stronger than AIC's for $l \geq 8$



Choosing the optimal number of control points

■ Procedure

- Simulated B-spline surface with $n + 1 = 5$ and $m + 1 = 7$ control points
- Superimposed by white noise with $\sigma = 2 \text{ mm}$
- Different sample sizes and different realizations
- Estimation of B-spline surfaces with varying number of control points
- Evaluation of each estimated curve with AIC and BIC
- Choosing the **surface with the best score** to be the **optimal** one



Choosing the optimal number of control points (cont'd)

l	AIC	BIC
900	11,7	5,7
900	5,11	5,7
900	11,11	5,7
3600	5,10	5,7
3600	11,11	5,7
3600	8,11	7,7
4900	7,11	5,9
4900	11,11	5,10
4900	5,9	5,9

Evaluation: AIC

- Distinct tendency to overestimate the number of control points
- Only in few cases at least one of the two parameters is determined correctly
- **Unsuitable** to determine the number of control points

Evaluation: BIC

- Satisfying results in case of the smaller sample sizes
- Becomes unstable with growing sample size
- At least one of the parameters is identified correctly
- **Suitable** to determine the number of control points



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Conclusion

- Conclusion:
 - Computation of synthetic covariance matrix
 - Mean positional error of 2.5 mm and spatial correlations of 0.95 at 5 m distance
 - Spatial correlations depend distance to each other
 - Modelling freeform surfaces by means of B-splines
 - Optimization of the number of control points with AIC and BIC
 - BIC is the more appropriate method regarding the simulated data
- Future work:
 - Integration of object based impacts
 - Evaluation by means of empirical values
 - Identification of additional criteria
 - Adoption of decorrelation techniques

Thank you for your attention

Contact:

- Dipl.-Ing. Stephanie Kauker
Institute of Engineering Geodesy, University of Stuttgart, Germany
Mail: stephanie.kauker@ingeo.uni-stuttgart.de
- M. Sc. Corinna Harmening
Department of Geodesy and Geoinformation,
Vienna University of Technology, Austria
Mail: corinna.harmening@geo.tuwien.ac.at